

IN THE CLAIMS

1 (Currently Amended). A method of developing a response compactor comprising:
adding at least two columns to a compactor matrix for each scan chain that, at the
same time as another scan chain, produces an unknown logic value;
forming a compactor matrix for a response compactor circuit; and
for each scan chain that produces an unknown logic value at the same time as
another scan chain produces an unknown value, adding at least two columns to said matrix.

Claim 2 (Canceled).

3 (Previously Presented). The method of claim 1 including obtaining the maximum
number of scan chains that can produce unknown logic values at the same time.

Claim 4 (Canceled).

5 (Previously Presented). The method of claim 1 including reducing the compactor
matrix using maximum compatibility class problem.

6 (Original). The method of claim 5 including eliminating from the matrix one of at
least two matching columns.

7 (Currently Amended). The method of claim 1 wherein adding at least two columns
to the compactor matrix includes adding at least two columns to the compactor matrix for every
combination of the number of unknown logic values plus one.

8 (Currently Amended). The method of claim 7 including adding values to rows of
said compactor the matrix rows such that for a first row the first column has a value one and the
succeeding columns have the value zero and a second row has the column value zero and the
succeeding columns have the followed by the column value one and a third row has a first

column of the column value values zero, followed by a second column of value zero, followed by a third the column of value one.

9 (Currently Amended). A response compactor formed by a process including the steps of:

obtaining a number of circuit outputs from scan chains that can produce unknown logic values at the same time; and

~~adding at least two columns to a compactor matrix for each such circuit output that, at the same time as another scan chain, produces unknown logic values.~~

for each scan chain that produces an unknown logic value at the same time as another scan chain produces an unknown value, adding at least two columns to said matrix.

10 (Currently Amended). The compactor of claim 9 formed by the process wherein obtaining the number of circuit outputs that produces unknown logic values at the same time includes determining a [[the]] maximum number of circuit outputs that can produce errors at the same time.

Claim 11 (Canceled).

12 (Currently Amended). The compactor of claim 9 formed by the [[a]] process including reducing the compactor matrix using maximum compatibility class problem.

13 (Previously Presented). The compactor of claim 12 wherein said compactor is formed of the process including eliminating from the matrix one of at least two matching columns.

14 (Previously Presented). The compactor of claim 9 formed by the process wherein adding at least two columns to the compactor matrix includes adding at least two columns to the compactor matrix for every combination of the number of circuit outputs that produces unknown logic values at the same time plus one.

15 (Currently Amended). The compactor of claim 14 formed by the process including adding values to ~~the matrix~~ rows of said compactor matrix, such that for a first row the first column has a value one and the succeeding columns have the value zero and a second row has the column value zero followed by the column value one and a third row has the column value zero, zero followed by the column value one.

16 (Currently Amended). A response compactor comprising:
a plurality of coupled exclusive OR gates to handle any number of scan chains with unknown logic values; and
a control, coupled to said gates, to add two columns to a compactor matrix for each scan chain that produces an unknown value at an unknown logic value at the same time as another scan chain produces an unknown logic value.

17 (Previously Presented). The compactor of claim 14 to handle any number of errors in the same scan cycle.

18 (Original). The compactor of claim 14 including the minimum number of scan outputs.

Claims 19-25 (Canceled).